

Search Notes

Application/Control No.

10/601,064

Examiner

C. SAYALA

Applicant(s)/Patent under
Reexamination

BAYDO ET AL.

Art Unit

1761

SEARCHED

| Class | Subclass | Date | Examiner |
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| 426 | 250 | 7/7/2007 | CS |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| search transcripts for USPAT, USPGPUBS, EPO, JPO, DERWENT, USOCR attached | 7/7/2007 | CS |
| not attached: search in GOOGLE, STN?CAS databases | 7/7/2007 | CS |
| PALM search for inventor's other cases conducted | 7/7/2007 | CS |
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